

Notice of References Cited	Application/Control No. 10/572,566		Applicant(s)/Patent Under Reexamination DUPLAN ET AL.	
	Examiner In Suk Bullock		Art Unit 1797	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,375,257	05-2008	Dath et al.	585/653
	B	US-			
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	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	EP 1195424	04-2002		ATOFINA Research	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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